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KSP92/93

High Voltage Transistor



PNP Epitaxial Silicon Transistor

Absolute Maximum Ratings T_a=25°C unless otherwise noted

Symbol	Parameter	Value	Units
V _{CBO}	Collector-Base Voltage		
	: KSP92	-300	V
	: KSP93	-200	V
V _{CEO}	Collector-Emitter Voltage		
	: KSP92	-300	V
	: KSP93	-200	V
V _{EBO}	Emitter-Base Voltage	-5	V
I _C	Collector Current	-500	mA
P _C	Collector Power Dissipation (T _a =25°C)	625	mW
	Derate above 25°C	5	mW/°C
P _C	Collector Power Dissipation (T _C =25°C)	1.5	W
	Derate above 25°C	12	mW/°C
T _J	Junction Temperature	150	°C
T _{STG}	Storage Temperature	-55 ~ 150	°C

Electrical Characteristics T_a =25°C unless otherwise noted

Symbol	Parameter	Test Condition	Min.	Max.	Units
BV _{CBO}	Collector-Base Breakdown Voltage : KSP92 : KSP93	I _C = -100μA, I _E =0	-300 -200		V
BV _{CEO}	* Collector-Emitter Breakdown Voltage : KSP92 : KSP93	I _C = -1mA, I _B =0	-300 -200		V V
BV _{EBO}	Emitter-Base Breakdown Voltage	I _E = -100μA, I _C =0	-5		V
I _{CBO}	Collector Cur-off Current : KSP92 : KSP93	V _{CB} = -200V, I _E =0 V _{CB} = -160V, I _E =0		-0.25 -0.25	μA μA
I _{EBO}	Emitter Cut-off Current	V _{EB} = -3V, I _C =0		-0.10	μΑ
h _{FE}	* DC Current Gain	V_{CE} = -10V, I_{CE} = -1mA V_{CE} = -10V, I_{CE} = -10mA V_{CE} = -10V, I_{CE} = -30mA	25 40 25		
V _{CE} (sat)	*Collector-Emitter Saturation Voltage	I _C = -20mA, I _B = -2mA		-0.50	V
V _{BE} (sat)	* Base-Emitter Saturation Voltage	I _C = -20mA, I _B = -2mA		-0.90	V
f _T	Current Gain Bandwidth Product	V _{CE} = -20V, I _C = -10mA, f=100MHz	50		MHz
f _T C _{ob}	Output Capacitance : KSP92 : KSP93	V _{CB} = -20V, I _E =0 f=1MHz		6 8	pF pF

* Pulse Test: PW≤300μs, Duty Cycle≤2%

Typical Characteristics

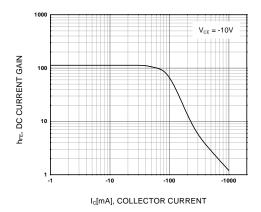


Figure 1. DC current Gain

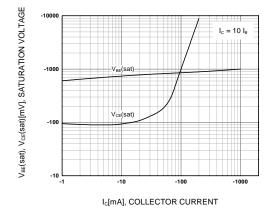


Figure 2. Saturation Voltage

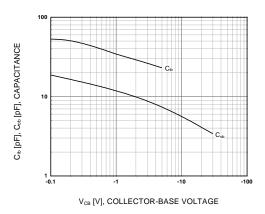


Figure 3. Capacitance

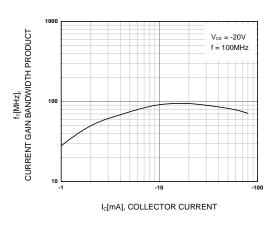


Figure 4. Current Gain Bandwidth Product

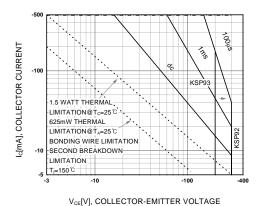


Figure 5. Active-Regio Safe Operating Area

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